

SN54HC20, SN74HC20 DUAL 4-INPUT POSITIVE-NAND GATES

SCLS086D – DECEMBER 1982 – REVISED FEBRUARY 2000

- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

description

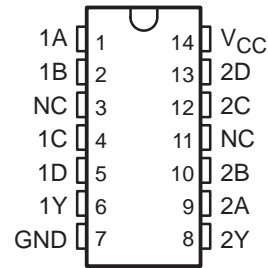
The 'HC20 devices contain two independent 4-input NAND gates. They perform the Boolean function $Y = A \cdot B \cdot C \cdot D$ or $Y = \overline{A + B + C + D}$ in positive logic.

The SN54HC20 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74HC20 is characterized for operation from -40°C to 85°C .

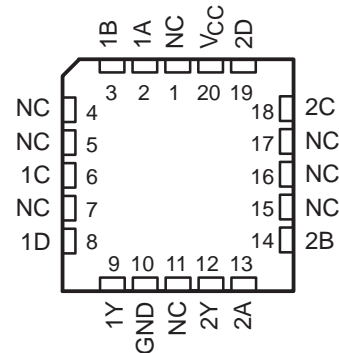
FUNCTION TABLE
(each gate)

INPUTS				OUTPUT
A	B	C	D	Y
H	H	H	H	L
L	X	X	X	H
X	L	X	X	H
X	X	L	X	H
X	X	X	L	H

SN54HC20 . . . J OR W PACKAGE
SN74HC20 . . . D, DB, N, OR PW PACKAGE
(TOP VIEW)

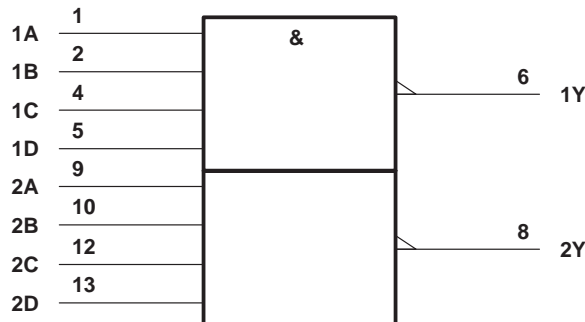


SN54HC20 . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, J, N, PW, and W packages.



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**TEXAS
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On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

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logic diagram (positive logic)



Pin numbers shown are for the D, DB, J, N, PW, and W packages.

absolute maximum ratings over operating free-air temperature range†

Supply voltage range, V_{CC}	-0.5 V to 7 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see Note 1)	± 20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$) (see Note 1)	± 20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	± 25 mA
Continuous current through V_{CC} or GND	± 50 mA
Package thermal impedance, θ_{JA} (see Note 2): D package	86°C/W
DB package	96°C/W
N package	80°C/W
PW package	113°C/W
Storage temperature range, T_{stg}	-65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 3)

		SN54HC20			SN74HC20			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	2	5	6	2	5	6	V
V_{IH}	High-level input voltage	$V_{CC} = 2$ V		1.5	1.5		V	
		$V_{CC} = 4.5$ V		3.15	3.15			
		$V_{CC} = 6$ V		4.2	4.2			
V_{IL}	Low-level input voltage	$V_{CC} = 2$ V		0	0.5	0	0.5	V
		$V_{CC} = 4.5$ V		0	1.35	0	1.35	
		$V_{CC} = 6$ V		0	1.8	0	1.8	
V_I	Input voltage	0	V_{CC}		0	V_{CC}		V
V_O	Output voltage	0	V_{CC}		0	V_{CC}		V
t_t	Input transition (rise and fall) time	$V_{CC} = 2$ V		0	1000	0	1000	ns
		$V_{CC} = 4.5$ V		0	500	0	500	
		$V_{CC} = 6$ V		0	400	0	400	
T_A	Operating free-air temperature	-55	125		-40	85		°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		V _{CC}	T _A = 25°C			SN54HC20		SN74HC20		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V _{OH}	V _I = V _{IH} or V _{IL}	I _{OH} = -20 μA	2 V	1.9	1.998		1.9		1.9	V	
			4.5 V	4.4	4.499		4.4		4.4		
			6 V	5.9	5.999		5.9		5.9		
		I _{OH} = -4 mA	4.5 V	3.98	4.3		3.7		3.84		
		I _{OH} = -5.2 mA	6 V	5.48	5.8		5.2		5.34		
V _{OL}	V _I = V _{IH} or V _{IL}	I _{OL} = 20 μA	2 V		0.002	0.1		0.1		0.1	V
			4.5 V		0.001	0.1		0.1		0.1	
			6 V		0.001	0.1		0.1		0.1	
		I _{OL} = 4 mA	4.5 V		0.17	0.26		0.4		0.33	
		I _{OL} = 5.2 mA	6 V		0.15	0.26		0.4		0.33	
I _I	V _I = V _{CC} or 0		6 V		±0.1	±100		±1000		±1000	nA
I _{CC}	V _I = V _{CC} or 0, I _O = 0		6 V			2		40		20	μA
C _i			2 V to 6 V		3	10		10		10	pF

switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC}	T _A = 25°C			SN54HC20		SN74HC20		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t _{pd}	A, B, C, or D	Y	2 V		45	110		165		140	ns
			4.5 V		14	22		33		28	
			6 V		11	19		28		24	
t _t		Y	2 V		27	75		110		95	ns
			4.5 V		9	15		22		19	
			6 V		7	13		19		16	

operating characteristics, T_A = 25°C

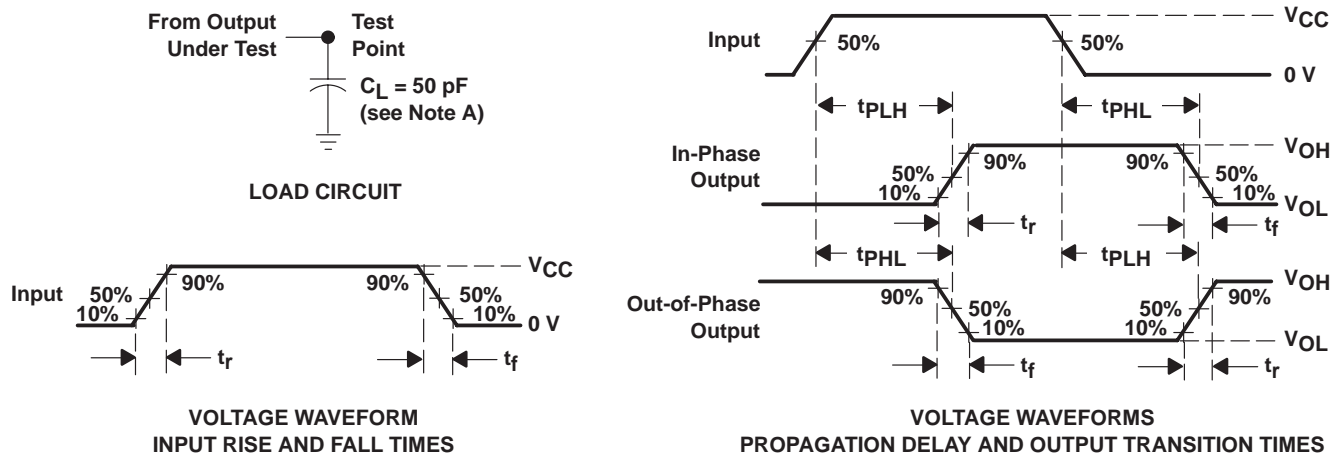
PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd} Power dissipation capacitance	No load	25	pF



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PARAMETER MEASUREMENT INFORMATION



- NOTES:
- A. C_L includes probe and test-fixture capacitance.
 - B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1$ MHz, $Z_O = 50 \Omega$, $t_r = 6$ ns, $t_f = 6$ ns.
 - C. The outputs are measured one at a time with one input transition per measurement.
 - D. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 1. Load Circuit and Voltage Waveforms

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SN54HC20, Dual 4-Input Positive-NAND Gates

DEVICE STATUS: **ACTIVE**

PARAMETER NAME	SN54HC20
Voltage Nodes (V)	6, 5, 2
Vcc range (V)	2.0 to 6.0
Input Level	CMOS
Output Level	CMOS
No. of Gates	2

FEATURES

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DESCRIPTION

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The 'HC20 devices contain two independent 4-input NAND gates. They perform the Boolean function $Y = (A) \cdot (B) \cdot (C) \cdot (D)$ or $Y = A + B + C + D$ in positive logic.

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TECHNICAL DOCUMENTS

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DATASHEET

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Full datasheet in Acrobat PDF: [scls086d.pdf](#) (67 KB) (Updated: 02/21/2000)

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- [Designing With Logic](#) (SDYA009C - Updated: 06/01/1997)
- [HCMOS Design Considerations](#) (SCLA007 - Updated: 04/01/1996)
- [Implications of Slow or Floating CMOS Inputs](#) (SCBA004C - Updated: 02/01/1998)
- [Input and Output Characteristics of Digital Integrated Circuits](#) (SDYA010 - Updated: 10/01/1996)
- [Live Insertion](#) (SDYA012 - Updated: 10/01/1996)
- [SN54/74HCT CMOS Logic Family Applications And Restrictions](#) (SCLA011 - Updated: 05/01/1996)
- [Using High Speed CMOS And Advanced CMOS In Systems With Multiple Vcc](#) (SCLA008 - Updated: 04/01/1996)

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- [Documentation Rules \(SAP\) And Ordering Information](#) (SZZU001B, 4 KB - Updated: 05/06/1999)
- [Logic Selection Guide Second Half 2000](#) (SDYU001N, 5035 KB - Updated: 04/17/2000)
- [MicroStar Junior BGA Design Summary](#) (SCET004, 167 KB - Updated: 07/28/2000)
- [More Power In Less Space - Technical Article](#) (SCAU001A, 850 KB - Updated: 03/01/1996)

PRICING/AVAILABILITY[▲ Back to Top](#)

<u>ORDERABLE DEVICE</u>	<u>PACKAGE</u>	<u>PINS</u>	<u>TEMP (°C)</u>	<u>STATUS</u>	<u>BUDGETARY PRICE US\$/UNIT QTY=1000+</u>	<u>PACK QTY</u>	<u>DSCC NUMBER</u>	<u>PRICING/AVAILABILITY</u>
84039012A	<u>FK</u>	20	-55 TO 125	ACTIVE	6.71	1		Check stock or order
JM38510/65003BCA	<u>J</u>	14	-55 TO 125	ACTIVE	6.22	1		Check stock or order
SN54HC20J	<u>J</u>	14	-55 TO 125	ACTIVE	0.87	1		Check stock or order
SNJ54HC20FK	<u>FK</u>	20	-55 TO 125	ACTIVE	6.71	1	84039012A	Check stock or order
SNJ54HC20J	<u>J</u>	14	-55 TO 125	ACTIVE	1.03	1		Check stock or order
SNJ54HC20W	<u>W</u>	14	-55 TO 125	ACTIVE	8.29	1	8403901DA	Check stock or order

Table Data Updated on: 11/10/2000